

**Notice of References Cited**

Application/Control No.

09/839,729

Applicant(s)/Patent Under  
Reexamination  
STRUHSAKER ET AL.

Examiner

Huy Q Phan

Art Unit

2685

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,812,951	09-1998	Ganesan et al.	455/445
	B	US-6,574,283	06-2003	Sakoda et al.	375/262
	C	US-5,459,727	10-1995	Vannucci, Giovanni	370/332
	D	US-6,667,965	12-2003	Yamaura et al.	370/347
	E	US-5,479,417	12-1995	Tsujimoto, Ichiro	714/776
	F	US-6,606,341	08-2003	Kanterakis et al.	375/130
	G	US-4,932,070	06-1990	Waters et al.	455/10
	H	US-6,269,093	07-2001	Alapuranen et al.	370/343
	I	US-5,283,780	02-1994	Schuchman et al.	370/312
	J	US-6,396,801	05-2002	Upton et al.	370/204
	K	US-6,167,024	12-2000	Upton et al.	370/203
	L	US-6,337,877	01-2002	Cole et al.	375/222
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.